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(MODIFIED) U.S. PATENT AND TRADEMARK OFFICE

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09/462,049

APPLICANT

Detlef Wiese et al..

FILING DATE

04/03/2000

GROUP

2747

INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT

(37 CFR 1.98(b))

U.S. PATENT DOCUMENTS

Examiner Initial	Cite No. <sup>1</sup>	Patent Number	Issue Date	Patentee	Class/ Subclass	Filing Date

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

Examiner Initial	Document Number	Publication Date	Country or Patent Office	Class/ Subclass	Translation Yes/No
L.S.	DE 37 84 120 T2	08/12/93	GERMANY		*No
L.S.	DE 34 43 041 A1	05/28/86	GERMANY		*No
L.S.	DE 41 35 977 A1	05/06/93	GERMANY		*No
L.S.	EP 0 327 101 A2	08/09/89	EUROPE		No
L.S.	EP 0 739 140 A2	10/23/96	EUROPE		No

OTHER DOCUMENTS

(Including Author, Title, Date, Relevant Pages, Place of Publication)

Examiner Initial	Cite No. <sup>1</sup>	
L.S.	C1	*English Abstract of DE 37 84 120 T2
L.S.	C2	*English Abstract of DE 34 43 041 A1
L.S.	C3	*English Abstract of DE 41 35 977 A1

EXAMINER	DATE CONSIDERED
LUN-SEE LAD	10/12/02

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered.  
Include copy of this form with next communication to applicant.

**LIST OF PRIOR ART CITED BY APPLICANT**  
(Filed on December 30, 1999)

Docket No.: GK-EIS-1028

Applicant(s): Detlef WEISE and Joerg RIMKUS

Serial No.: (Int'l Appln. PCT/EP98/03981 filed June 30, 1998) Group:

Filed: Examiner:

**U.S. PATENT DOCUMENTS**

Exam. Init		Document Number	Date	Name	Class	Sub-Class	Filing Date Appropriate
L.S.	AA	✓ 4,899,384	02/06/90	Crouse, et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						

**FOREIGN PATENT DOCUMENTS**

		Document Number	Date	Country	CLASS	Sub-Class	Translation	
							YES	NO
L.S.	AL	DE 41 35 977	05/06/93	GERMANY				
L.S.	AM	EP 0 596 648	05/11/94	EUROPEAN				
	AN							
	AO							
	AP							

**OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)**

	AS	
	AT	
	AU	
	AV	

Examiner: LUN-SEE LAD

Date: 10/20/04

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.